

September 2013

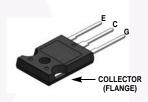
FGH25T120SMD 1200 V, 25 A Field Stop Trench IGBT

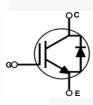
Features

- FS Trench Technology, Positive Temperature Coefficient
- High Speed Switching
- + Low Saturation Voltage: V_{CE(sat)} =1.8 V @ I_C = 25 A
- 100% of The Parts Tested for ILM(1)
- High Input Impedance
- RoHS Compliant

Applications

Solar Inverter, Welder, UPS & PFC Applications. •





Using innovative field stop trench IGBT technology, Fairchild's

new series of field stop trench IGBTs offer the optimum

inverter, UPS, welder and PFC applications.

performance for hard switching application such as solar

General Description

Absolute Maximum Ratings T_C = 25°C unless otherwise noted

Symbol	Description		Ratings	Unit
V _{CES}	Collector to Emitter Voltage		1200	V
V _{GES}	Gate to Emitter Voltage		±25	V
	Transient Gate to Emitter Voltage		±30	V
L	Collector Current	@ T _C = 25 ^o C	50	A
I _C	Collector Current	@ $T_{\rm C} = 100^{\rm o}{\rm C}$	25	A
I _{LM} (1)	Clamped Inductive Load Current	@ T _C = 25 ^o C	100	A
I _{CM} (2)	Pulsed Collector Current		100	A
I _F	Diode Continuous Forward Current	@ T _C = 25 ^o C	50	A
	Diode Continuous Forward Current	@ T _C = 100 ^o C	25	A
I _{FM}	Diode Maximum Forward Current		200	A
P _D	Maximum Power Dissipation $@T_{C} = 25^{\circ}C$		428	W
	Maximum Power Dissipation	@ T _C = 100°C	214	W
TJ	Operating Junction Temperature		-55 to +175	°C
T _{stg}	Storage Temperature Range		-55 to +175	°C
TL	Maximum Lead Temp. for soldering Purposes, 1/8" from case for 5 seconds		300	°C

Thermal Characteristics

Symbol	Parameter	Тур.	Max.	Unit
$R_{\theta JC}$ (IGBT)	Thermal Resistance, Junction to Case		0.35	°C/W
$R_{\theta JC}$ (Diode)	Thermal Resistance, Junction to Case		1.4	°C/W
$R_{ extsf{ heta}JA}$	Thermal Resistance, Junction to Ambient		40	°C/W

Notes:

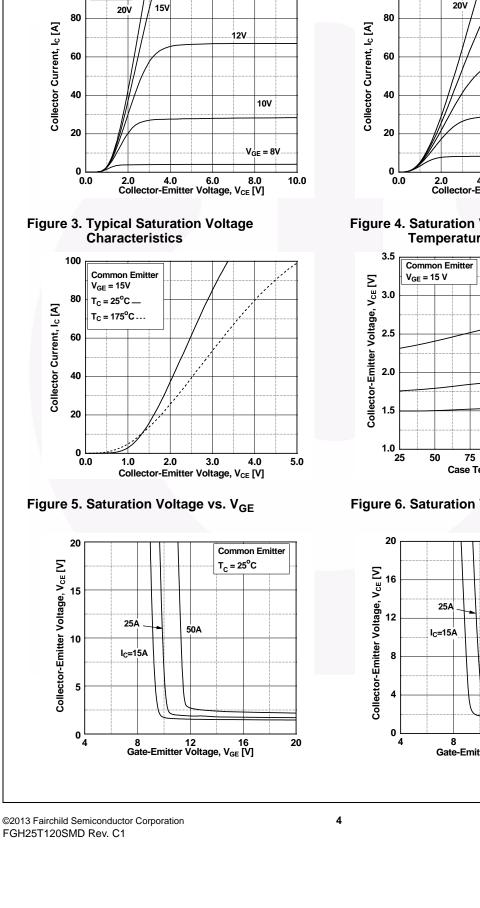
1. Vcc = 600 V, V_{GE} = 15 V, I_C = 100 A, R_G = 23 Ω , Inductive Load 2. Limited by Tjmax

Device MarkingDeviceFGH25T120SMDFGH25T120SMD_F155		PackageReel SizeTO-247G03-		e Tape Width		Quantity 30		
								Electric
Symbol	bol Parameter		Test Co	onditions	Min.	Тур.	Max.	Unit
Off Charac	teristics							
BV _{CES}	Collector to Emitter Breakdown Voltage		V _{GE} = 0 V, I _C = 250 uA		1200	-	-	V
ICES		Cut-Off Current	$V_{GE} = 0 V, T_C = 250 u A$ $V_{CE} = V_{CES}, V_{GE} = 0 V$		-	-	250	uA
I _{GES}		age Current	$V_{CE} = V_{CES}, V_{GE} = 0$ V $V_{GE} = V_{GES}, V_{CE} = 0$ V		-	-	±400	nA
GES			•GE = •GES, •CE = 0 •					
On Charac	teristics							
V _{GE(th)}	G-E Three	shold Voltage	I_{C} = 25 mA, V_{CE} = V_{GE}		4.9	6.2	7.5	V
			$I_{C} = 25 \text{ A}, V_{GE} = 15 \text{ V}$ $T_{C} = 25^{\circ}\text{C}$		-	1.8	2.4	V
V _{CE(sat)}	Collector	to Emitter Saturation Voltage	$I_{C} = 25 \text{ A}, V_{GE} = 15 \text{ V},$ $T_{C} = 175^{\circ}\text{C}$		-	1.9	-	V
Dynamic C	haracteris	tics						
Cies	Input Cap	pacitance			-	2800	-	pF
C _{oes}	Output Ca	apacitance	V _{CE} = 30 V _, V _G f = 1MHz	_E = 0 V,	-	105	-	pF
C _{res}	Reverse ⁻	Transfer Capacitance			-	60	-	pF
Switching	Characteri	istics						
t _{d(on)}	Turn-On I	Delay Time	V _{CC} = 600 V, I _C = 25 A,		-	40	-	ns
t _r	Rise Time	9			-	45	-	ns
t _{d(off)}	Turn-Off [Delay Time			-	490	-	ns
t _f	Fall Time		$R_G = 23 \Omega$, V_G	_E = 15 V,	-	12	-	ns
E _{on}	Turn-On S	Switching Loss	Inductive Load	$1_{\rm C} = 25^{\circ}{\rm C}$	-	1.74	-	mJ
E _{off}	Turn-Off S	Switching Loss	1		-	0.56	-	mJ
E _{ts}	Total Swit	ching Loss	1		-	2.30	-	mJ
t _{d(on)}	Turn-On I	Delay Time			-	40	-	ns
t _r	Rise Time	9	1		-	48	-	ns
t _{d(off)}	Turn-Off [Delay Time	V _{CC} = 600 V, I ₀	_c = 25 A,	-	520	-	ns
t _f	Fall Time		$R_{G} = 23 \Omega$, $V_{GE} = 15 V$,		-	64	-	ns
Eon	Turn-On S	Switching Loss	Inductive Load	$1_{\rm C} = 1/5^{\circ}{\rm C}$	-	2.94	-	mJ
E _{off}	Turn-Off S	Switching Loss	-		-	1.09	-	mJ
E _{ts}	Total Swit	ching Loss			-	4.03	-	mJ
Qg	Total Gate	e Charge			-	225	-	nC
Q _{ge}	Gate to E	mitter Charge	$V_{CE} = 600 \text{ V}, I_C = 25 \text{ A},$		-	20	-	nC
Q _{gc}	Gate to C	ollector Charge	V _{GE} = 15 V		-	128	-	nC

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
V _{FM}	Diode Forward Voltage	I _F = 25 A, T _C = 25 ^o C	-	2.8	3.7	V
		I _F = 25 A, T _C = 175°C	-	2.1	-	V
t _{rr}	Diode Reverse Recovery Time	$V_R = 600 \text{ V}, I_F = 25 \text{ A},$ $di_F/dt = 200 \text{ A/us}, T_C = 25^{\circ}\text{C}$	-	60	-	ns
I _{rr}	Diode Peak Reverse Recovery Current		-	6.6	-	А
Q _{rr}	Diode Reverse Recovery Charge		-	197	-	nC
E _{rec}	Reverse Recovery Energy	$V_R = 600 V$, $I_F = 25 A$, $d_iF/dt = 200 A/us$, $T_C = 175^{o}C$	-	330	-	uJ
t _{rr}	Diode Reverse Recovery Time		-	325	-	ns
I _{rr}	Diode Peak Reverse Recovery Current		-	13	-	А
Q _{rr}	Diode Reverse Recovery Charge	*	-	2113	-	nC

Electrical Characteristics of the DIODE T_c = 25°C unless otherwise noted

FGH25T120SMD — 1200 V, 25 A Field Stop Trench IGBT



Typical Performance Characteristics

Figure 1. Typical Output Characteristics

100

 $T_C = 25^{\circ}C$

Figure 2. Typical Output Characteristics

20V

12V 10V V_{GE} = 8V 2.0 4.0 6.0 8.0 Collector-Emitter Voltage, V_{CE} [V] 10.0

15V



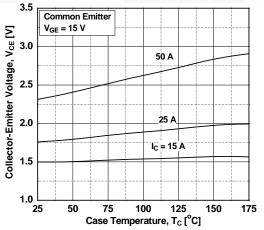
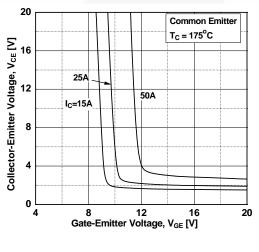


Figure 6. Saturation Voltage vs. V_{GE}



T_C = 175°C

100

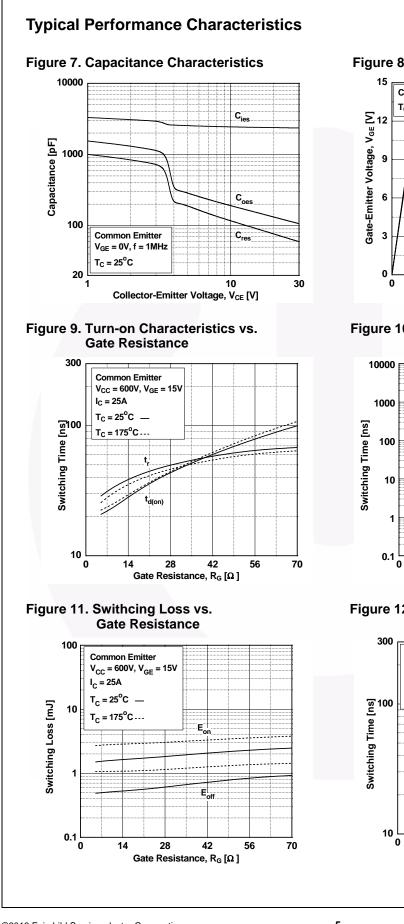
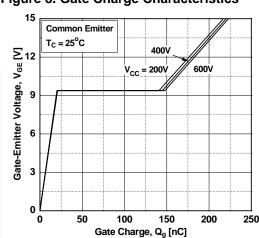


Figure 8. Gate Charge Characteristics





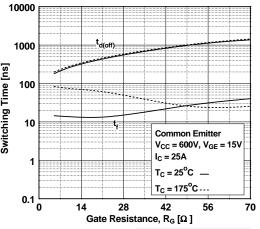
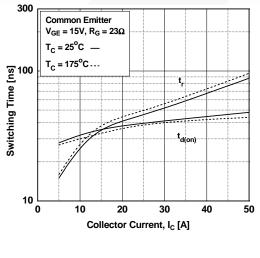
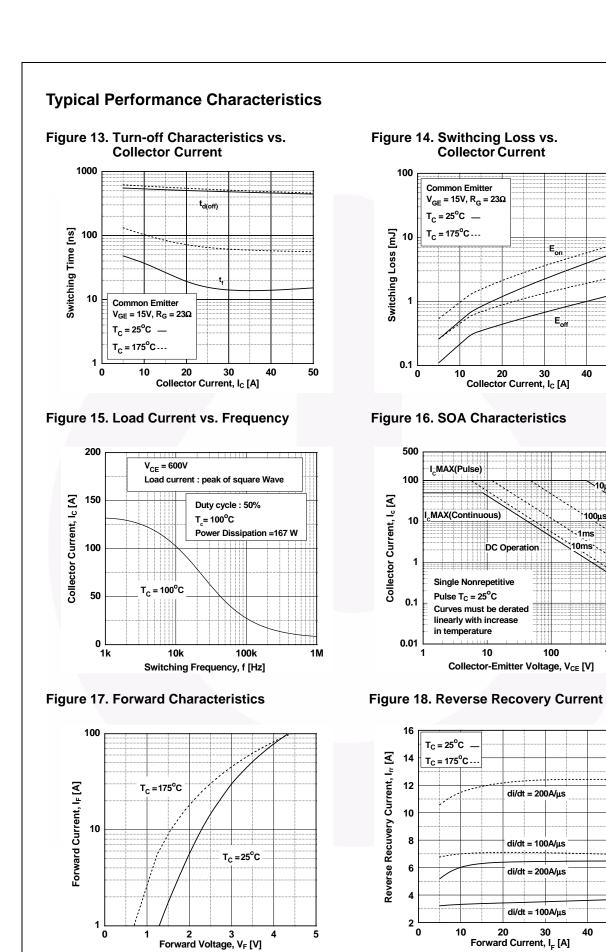
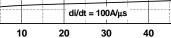


Figure 12. Turn-on Characteristics vs. Collector Current







Forward Current, I_E [A]

di/dt = 200A/µs

di/dt = 100A/µs

di/dt = 200A/µs

Collector Current

20

Collector Current, Ic [A]

DC Operation

E_{on}

E_{of}

40

10µs

1000

100us

1ms

10ms

100

Collector-Emitter Voltage, V_{CE} [V]

50

30

Common Emitter V_{GE} = 15V, R_G = 23Ω

10

I_MAX(Pulse)

MAX(Continuous)

Single Nonrepetitive

Curves must be derated linearly with increase in temperature

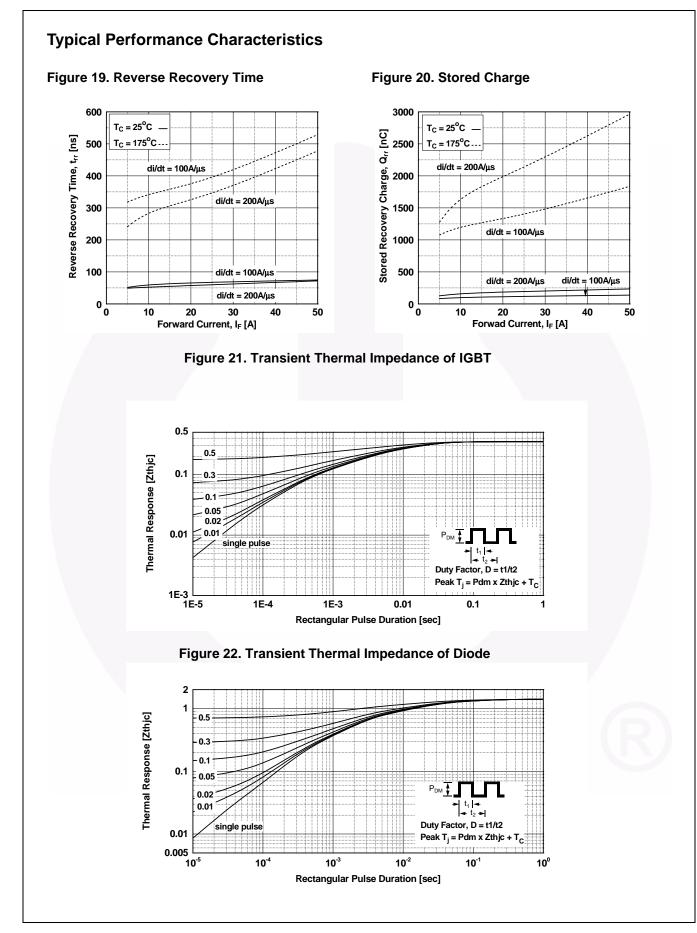
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Pulse $T_C = 25^{\circ}C$

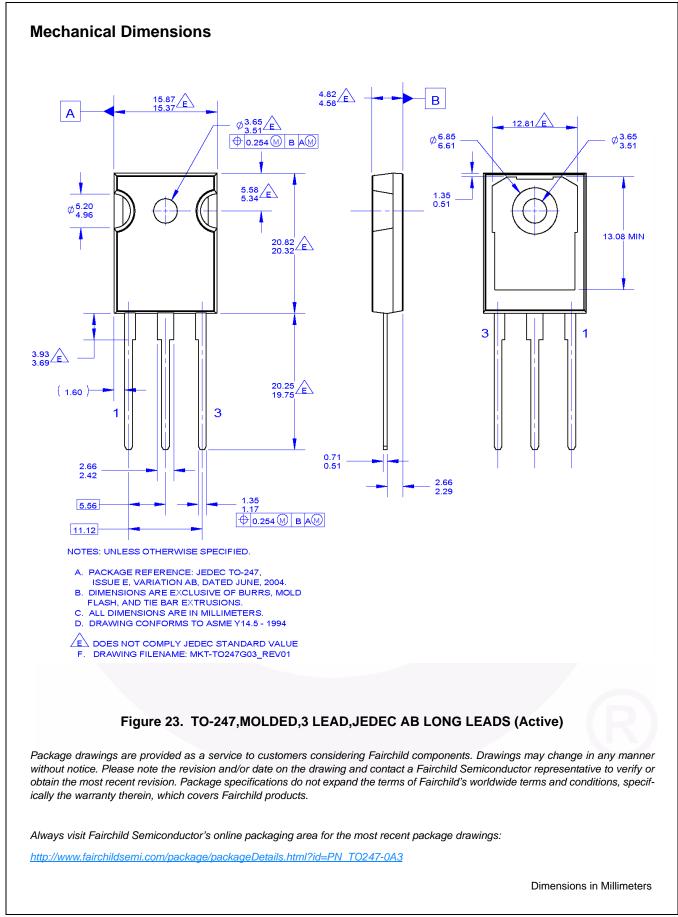
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FGH25T120SMD — 1200 V, 25 A Field Stop Trench IGBT





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